A Needs-Based Assessment of Nanotechnology Environmental Health & Safety

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National Institute of Standards and Technology Technology Administration U.S. Department of Commerce



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Outline

- USMS initial results
- Nanotechnology-EHS focus



Nanomaterials and the USMS Assessment: Observations

High demand for new advanced measurement instrumentation for accurate, high resolution characterization of physical, chemical and biological properties of materials at nanometer dimensions

Principal measurement barrier to innovation is the absence of measurement instruments, techniques and methods capable of accurately characterizing the behavior of complex materials systems and structures Absence of regulations is having a serious impact on innovation

Timely delivery of materials measurement solutions is increasingly challenging

Key factor driving the need for innovation is anticipation of the production/marketplace needs for the evaluation of Materials Performance, Manufacturability, and Reliability







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What are the Components of an Authenticated MN (How)?

- MN Template
 - Technological innovation at stake
 - Economic significance of the innovation
 - Technical barrier to the innovation
 - Stage of innovation at which technical barrier appears
 - Measurement-problem part of the technical barrier
 - Potential solutions to the measurement problem
 - Potential providers of these solutions
- Tags / Indicators
 - MN Characteristics that may be used to compare MNs
- Authentication
 - Evidence that MN represents a significant portion of Measurement Solution Users



31 Measurement Needs (MNs) submitted by Scientists & Engineers – examples include:

- o Nano-scale drug delivery
- o Toxicology of nanoparticles in biological systems
- Real time measurements for pharmaceuticals and biologics manufacturing
- Advanced drug delivery systems, including implantable devices that automatically administer drugs and sense drug levels
- o Sensors for airborne chemicals or other toxins
- o Nanocrystal biophotonic sensors
- o Nanomagnetic MRI contrast agents
- o Inhalation insulin delivery/diabetes management
- o Small particle monitoring for advanced semiconductor manufacturing
- o Health care/nanotechnology cancer diagnosis and treatment
- o Quality control in cytometry for improved clinical diagnostics
- o C60 carbon nanomaterials for nanobiotechnology



104 Roadmap Measurement Needs (RMNs) identifed from roadmaps, workshop reports, and white papers – *sources include:*

| Roadmap, White Paper or Workshop Report | Year | Source | # of RMNs |
|--|--------|--|-----------------|
| Strategy for Nanotechnology-Related Environmental, Health, and Safety Research | 2008 | http://www.nano.gov/ | 4 |
| Toxicology steps up to nanotechnology safety | 2008 | http://www.rdmag.com/ | 7 |
| Strategic Plan for NIOSH Nanotechnology Research and Guidance | 2008 | http://www.cdc.gov/niosh/topics/nanotech/strat_plan.ht ml_ | 3 |
| Nanotechnology - A report of the US FDA Nanotechnology Task Force (FDA) | 2007 | http://www.fda.gov/nanotechnology/taskforce/report2007 .html | 3 |
| Prioritization of EHS Research Needs for Engineered Nanoscale Materials - An interim document for public comment (NEHI Working Group) | 2007 | http://www.nano.gov/Prioritization_EHS_Research_Nee ds_Engineered_Nanoscale_Materials.pdf | 21 |
| Nanomaterials in the workplace - Policy and planning workshop on Occupational Safety | | http://www.rand.org/pubs/conf_proceedings/2006/RAND | 2 |
| EHS Research Needs for Engine | eered | Nanoscale Materials | 6 |
| د (NNI) | | | 3 |
| The inational manotechnology initiative - Strategic Pran | 2007 | nttp://www.nano.gowntmi/about/strategicpian.ntmi | 2 |
| Nanotechnology environmental health & safety standards | 2007 | http://www.iso.org/iso/iso-focus-index_ | 4 |
| EHS Research Needs for Engineered Nanoscale Materials | 2006 | nttp://www.nano.gow/NNL_EHS_research_needs.pdf | 31 |
| Prioritization of EHS Research N | leeds | for Engineered | 1 |
| Nanoscale Materials (NEHI) | 100000 | | 2 |
| | | | |
| Assessment Study on Sensors and Automation in the Industries of the Future | 2004 | n/pdfs/doe_report.pdf | 1 |
| International Technology Roadmap for Semiconductors | 2004 | http://www.itrs.net/Common/2004Update/2004Update.ht | 1 |
| Chemical Industry R&D Roadmap for Nanomaterials By Design | 2003 | http://www.chemicalvision2020.org/pdfs/nano_roadmap. pdf | 1 |
| Nanoscale Science and Engineering for Agriculture and Food Systems | 2003 | http://www.nseafs.comell.edu/web.roadmap.pdf | 1 |
| Nanobiotechnology | 2003 | http://www.nano.gov/nni_nanobiotechnology_rpt.pdf | 3 |
| Nanotechnology | 2003 | http://www.technology.gov/reports/TechPolicy/Nanotech /030523.pdf | 2 |
| Nanotechnology and the Environment: Applications and Implications STAR Progress Review Workshop | 2002 | http://es.epa.gov/ncer/publications/workshop/nano_proc eed.pdf | 3 |
| Nanotechnology Innovation for Chemical, Biological, Radiological, and Explosive Detection and Protection | 2002 | http://www.wtec.org/nanoreports/cbre/CBRE_Detection _11_1_02_hires.pdf | 2 |
| Vision 2020 Materials Technology Roadmap | 2000 | http://www.eere.energy.gov/industry/chemicals/pdfs/mat erials_tech_roadmap.pdf | 1 |
| | | U.S. Department of Commerce | nnologies, Inc. |

Preliminary Inferential Analysis of nano-EHS Measurement Needs (MNs) & Roadmap Measurement Needs (RMNs) Data analyzed from 31 MNs and 104 RMNs





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| | | | | | Mea | asur | eme | nt S | olu | tion | Barri | ers | | | | |
|--------------------------------------|-----------------------------|---------------|----------|---|-------------|---------|-------------------------------|--------------------------|------------------|----------------------|-------------|------------|---------------------|-------|----------------------|-----------|
| Stage of Technological Innovation | Acceptability/Compatibility | Accessibility | Accuracy | Data, Data Collection and/or Retrieval | Destructive | Expense | Lack of fundamental knowledge | Multiple Solutions Exist | Not Standardized | Production Readiness | Reliability | Resolution | Small Market Demand | Speed | System-Level Problem | Workforce |
| Applied Research | 2 | 3 | 101 | 22 | 3 | 2 | - 44 | - 16 | 18 | 6 | 72 | 48 | 2 | - 9 | - 38 | 2 |
| Production | 2 | 2 | 8 | 4 | | 1 | 6 | 2 | 7 | 3 | 5 | 4 | | 3 | 3 | 4 |
| Market | | | 2 | 2 | | | | | 4 | | 4 | | | | | |
| End-use | | | | | | | | | | | | | | | | |



| | | | | | | | | | Me | easi | irem | ent | Sol | utio | ons | | | | | | | | | | |
|------------------------|---------------------------|---------------------------|---|-----------------------------------|----------|-----------------------------------|----------|--------------|-------------------|-------------------|-----------------------|-------------------|--------------------|--------------------|---------------|---------|----------------|-------------|----------------------------------|-----------------------------------|---------------|---------------------|--------------------|-------------------------|----------------------|
| | | | Infr | astru | ctur | e | | | Products | | | | | | | | | | | | Services | | | | |
| Stage of Technological | oordination/ facilitation | ata Collection/ Retrieval | evelopment for easurement Technology | undamental Scientific nowledge | rotocols | esearch for Measurement cience | tandards | ser Facility | alibration Method | omputation Method | easurement Instrument | easurement Method | etrics/ Benchmarks | aw Properties Data | eference Data | oftware | tability Tests | tandard/CRM | est Methods - Production cale | est Methods - Consumer roducts | alidated Data | alibration Services | xpert Consultation | ternational Recognition | d Party Verification |
| Innovation | Ŭ | õ | Ω | ΞŻ | Ы | R. S. | SI | ñ | Ű | Ŭ | Σ | Σ | Σ | ñ | ĕ | õ | S | S | Š | ГĔ | Š | Ű | ш | -= | 31 |
| Applied Research | | 2 | 21 | 8 | 87 | 15 | 10 | 4 | 3 | - 7 | - 95 | - 97 | 3 | - 9 | - 4 | 3 | 2 | - 9 | 1 | | | | 3 | | |
| Production | | | 4 | | 8 | | 4 | | | 2 | 10 | 10 | | | 1 | | | 8 | 2 | | | 1 | | | |
| Market | | | | | 2 | | 4 | | | 2 | | | | | | | | 2 | 1 | 1 | | | | | |
| End-use | | | | | | | | | | | | | | | | | | | | | | | | | |



| | | | | | М | easu | reme | nt So | lutio | n Ba | rriers | 5 | | | | |
|--------------------------|-----------------------------|---------------|----------|---|-------------|---------|----------------------------------|--------------------------|------------------|----------------------|-------------|------------|---------------------|-------|----------------------|-----------|
| Aggregated Measurands | Acceptability/compatibility | Accessibility | Accuracy | Data, data collection and/or retrieval | Destructive | Expense | Lack of fundamental knowledge | Multiple solutions exist | Not standardized | Production readiness | Reliability | Resolution | Small market demand | Speed | System-level problem | Workforce |
| Classical | 2 | 1 | 80 | 21 | 2 | 2 | 35 | 16 | 21 | 5 | 65 | 38 | 1 | - 7 | 32 | 4 |
| Functional | 1 | 4 | 15 | 7 | 1 | | 8 | 1 | 5 | 2 | 6 | 6 | | 1 | 6 | 2 |
| Performance | | | | | | | | | | | | | | | | |
| Structural | 1 | | 16 | | | 1 | 7 | 1 | 3 | 2 | 10 | 8 | 1 | 4 | 3 | |



| | | Stage of | Technolo | ogical Inn | ovation |
|----------|---------------------------|-----------------|-----------|------------|---------|
| | | pplied Research | roduction | arket | nd-Use |
| <u> </u> | Neasurand | A | Р | Σ | Ē |
| 2 | Biological | 7 | | 2 | |
| ssic | Chemical | 23 | 7 | | |
| | Physical | 31 | | 2 | |
| <u> </u> | Physiological | 36 | 8 | | |
| | All | 15 | 2 | | |
| | Electronic/Electrical | | | | |
| _ | Magnetic | 2 | | | |
| na | Optical | 3 | 2 | | |
| Ĕ | Photonic | | | | |
| E. | Radio frequency | | | | |
| - | Thermal - Thermochemical | | | | |
| | Thermal - Thermodynamic | | | | |
| | Thermal - Thermophysical | | | | |
| nce | Computational Performance | | | | |
| orma | Software Performance | | | | |
| Perf | System Performance | | | | |
| a | Kinetic | | | | |
| tur | Mechanical | 3 | 1 | | |
| Inc | Molecular | 7 | | | |
| S | Spatial | 10 | | | |



| | | | | | | Μ | easu | ireme | nt So | lutio | n Ba | rriers | 5 | | | | | |
|----------|---------------------------|-----------------------------|---------------|----------|---|-------------|---------|----------------------------------|--------------------------|------------------|----------------------|-------------|------------|---------------------|-------|----------------------|-----------|-----------------|
| | Measurand | Acceptability/compatibility | Accessibility | Accuracy | Data, data collection and/or retrieval | Destructive | Expense | Lack of fundamental knowledge | Multiple solutions exist | Not standardized | Production readiness | Reliability | Resolution | Small market demand | Speed | System-level problem | Workforce | |
| a | Biological | | | 7 | | | | 2 | 2 | 3 | | 9 | 2 | | 2 | | | |
| sic | Chemical | | 1 | - 22 | 7 | | | 8 | 4 | 3 | 1 | 18 | 17 | | 3 | 3 | 1 | |
| as a | Physical | 2 | | - 26 | 11 | 2 | 1 | 7 | | 9 | 1 | 17 | 10 | | | 6 | | |
| 0 | Physiological | | | - 25 | 3 | | 1 | 18 | 10 | 6 | 3 | 21 | 9 | 1 | 2 | 23 | 3 | |
| | All | 1 | 4 | 8 | 7 | 1 | | 4 | 1 | 5 | 2 | 6 | 3 | | 1 | 6 | 2 | |
| | Electronic/Electrical | | | | | | | | | | | | | | | | | |
| | Magnetic | | | 2 | | | | 2 | | | | | 2 | | | | | |
| na | Optical | | | 5 | | | | 2 | | | | | 1 | | | | | |
| ctio | Photonic | | | | | | | | | | | | | | | | | |
| Ĩ | Radio frequency | | | | | | | | | | | | | | | | | |
| <u> </u> | Thermal - Thermochemical | | | | | | | | | | | | | | | | | |
| | Thermal - Thermodynamic | | | | | | | | | | | | | | | | | |
| | Thermal - Thermophysical | | | | | | | | | | | | | | | | | |
| ce | Computational Performance | | | | | | | | | | | | | | | | | |
| rman | Software Performance | | | | | | | | | | | | | | | | | |
| Perfo | System Performance | | | | | | | | | | | | | | | | | |
| a | Kinetic | | | | | | | | | | | | | | | | | |
| tur | Mechanical | 1 | | 3 | | | | | | 1 | | 2 | 2 | | 2 | 1 | | |
| IUC | Molecular | | | 5 | | | | 3 | 1 | | 2 | 3 | | | 1 | | | |
| St | Spatial | | | 8 | | | 1 | 4 | | 2 | | 5 | 6 | 1 | 1 | 2 | | echnologies. Ir |
| | • | | | | | | | - | | | | | | | | | | 0 |

| | | | | | Ме | asu | reme | nt S | olut | ion l | Barri | ers | | | | |
|-------------------------------------|-----------------------------|---------------|----------|---|-------------|---------|-------------------------------|--------------------------|------------------|----------------------|-------------|------------|---------------------|-------|----------------------|-----------|
| Aggregated Measurement Solutions | Acceptability/Compatibility | Accessibility | Accuracy | Data, Data Collection and/or Retrieval | Destructive | Expense | Lack of fundamental knowledge | Multiple Solutions Exist | Not Standardized | Production Readiness | Reliability | Resolution | Small Market Demand | Speed | System-Level Problem | Workforce |
| Infrastructure | 4 | 5 | 125 | 35 | 3 | 4 | - 57 | 18 | -27 | 5 | 86 | 63 | - 2 | 10 | - 35 | 4 |
| Products | 5 | 7 | 189 | 40 | 5 | 4 | 82 | - 36 | - 45 | 17 | 149 | 87 | - 4 | - 23 | - 75 | 10 |
| Services | 1 | | | 3 | | | 2 | | 1 | | | | | | - 4 | 1 |



CONCLUSIONS

- Measurement Needs and Roadmap Measurement Needs are being assessed within the Nano-EHS sector
- Preliminary indications are that Nano-EHS is *early-stage* in its development of measurement solutions
- Nano-EHS measurement needs will *push the envelope* of metrology equipment in the near future
- A concerted effort across multiple disciplines is needed to solve many of the Nano-EHS measurement needs
- It is critical to engage experts in this activity for their opinions on techniques, priorities and strategic directions



PURPOSE OF WORKSHOP

- Engage experts in the field in the development of Measurement Needs to make an accurate assessment of the state-of-the-art Nano-EHS USMS
- Initiate a dialogue about the best means for obtaining measurement *solutions* to addressing measurement needs
- Create a new opportunity for networking among experts in the Nano-EHS research and business sector

